## GENERAL DESCRIPTION

New generation, high-voltage, high-speed switching npn transistor in a plastic full-pack envelope intended for use in horizontal deflection circuits of large screen colour television receivers up to 32 kHz .

## QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {cESM }}$ | Collector-emitter voltage peak value | $\mathrm{V}_{\text {BE }}=0 \mathrm{~V}$ |  | 1500 | V |
| $\mathrm{V}_{\text {CEO }}^{\text {CEM }}$ | Collector-emitter voltage (open base) |  | - | 800 | V |
| $\mathrm{I}_{\mathrm{c}}$ | Collector current (DC) |  |  | 12 | A |
| $\mathrm{I}_{\mathrm{CM}}$ | Collector current peak value |  |  | 30 | A |
| $\mathrm{P}_{\text {tot }}$ | Total power dissipation | $\mathrm{T}_{\text {hs }} \leq 25^{\circ} \mathrm{C}$ | - | 45 | W |
| $\mathrm{V}_{\text {cesat }}$ | Collector-emitter saturation voltage Collector saturation current | $\mathrm{I}_{\mathrm{C}}=8.0 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=1.6 \mathrm{~A}$ | 8.0 | 5.0 | V |
| $\mathrm{t}_{\text {csat }}$ | Fall time | $\mathrm{I}_{\mathrm{CM}}=8.0 \mathrm{~A} ; \mathrm{I}_{\mathrm{B} \text { (end) }}=1.1 \mathrm{~A}$ | 0.2 | 0.35 | us |

PINNING - SOT199

| PIN | DESCRIPTION |
| :---: | :--- |
| 1 | base |
| 2 | collector |
| 3 | emitter |
| case | isolated |

## PIN CONFIGURATION



SYMBOL


## LIMITING VALUES

Limiting values in accordance with the Absolute Maximum Rating System (IEC 134)

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {CESM }}$ | Collector-emitter voltage peak value | $\mathrm{V}_{\text {BE }}=0 \mathrm{~V}$ |  | 1500 | V |
| $V_{\text {ceo }}$ | Collector-emitter voltage (open base) |  |  | 800 | V |
| $\mathrm{I}_{\mathrm{c}}$ | Collector current (DC) |  |  | 12 | A |
| $\mathrm{ICM}_{\text {cm }}$ | Collector current peak value Base current (DC) |  |  | 12 8 8 | A |
| $\mathrm{I}_{\text {gm }}$ | Base current peak value |  | - | 12 | A |
| $\mathrm{I}_{\text {B(AV) }}$ | Reverse base current | average over any 20 ms period |  | 200 | mA |
| $\mathrm{P}^{-1 \mathrm{Bm}}$ | Reverse base current peak value ${ }^{1}$ |  |  | 7 | A |
| $\mathrm{P}_{\text {tot }}$ | Total power dissipation | $\mathrm{T}_{\text {hs }} \leq 25^{\circ} \mathrm{C}$ | -65 | 45 | W |
| $\mathrm{T}_{\text {stg }}$ | Storage temperature Junction temperature |  | -65 | 150 150 | ${ }^{\circ} \mathrm{C}$ |

## THERMAL RESISTANCES

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
| :--- | :--- | :--- | :---: | :---: | :---: |
| $\mathrm{R}_{\text {th } j \text {-hs }}$ | Junction to heatsink | without heatsink compound | - | 3.7 | K/W |
| $\mathrm{R}_{\text {th } j \text {-hs }}$ | Junction to heatsink | with heatsink compound | - | 2.8 | K/W |
| $\mathrm{R}_{\text {th } j-\mathrm{a}}$ | Junction to ambient | in free air | 35 | - | K/W |

[^0]
## ISOLATION LIMITING VALUE \& CHARACTERISTIC

$\mathrm{T}_{\text {hs }}=25^{\circ} \mathrm{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| :--- | :--- | :--- | :---: | :---: | :---: | :---: |
| V $_{\text {isol }}$ | Repetitive peak voltage from all <br> three terminals to external <br> heatsink | R.H. $\leq 65 \%$; clean and dustfree | - |  | 2500 | V |
| $\mathrm{C}_{\text {isol }}$ | Capacitance from T2 to external <br> heatsink | $\mathrm{f}=1 \mathrm{MHz}$ | - | 22 | - | pF |

## STATIC CHARACTERISTICS

$\mathrm{T}_{\mathrm{hs}}=25^{\circ} \mathrm{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {CES }}$ | Collector cut-off current ${ }^{2}$ | $\mathrm{V}_{\text {BE }}=0 \mathrm{~V}$; $\mathrm{V}_{\text {CE }}=\mathrm{V}_{\text {CESM max }}$ |  |  | 1.0 | mA |
| $\mathrm{I}_{\text {ces }}$ |  | $\mathrm{V}_{\mathrm{BE}}=0 \mathrm{~V}^{\prime} \mathrm{V}_{\mathrm{CE}}=\mathrm{V}_{\mathrm{CESMmax}}$ |  |  | 2.0 | mA |
| EBO | Emitter cut-off current | $\mathrm{V}_{\text {EB }}=7.5 \mathrm{~V} ; \mathrm{I}_{\mathrm{C}}=0 \mathrm{~A}$ |  | - | 1.0 | mA |
| $\mathrm{BV}_{\text {Ebo }}$ | Emitter-base breakdown voltage | $\mathrm{I}_{\mathrm{B}}=1 \mathrm{~mA}$ | 7.5 | 13.5 |  | V |
| $\mathrm{V}_{\text {CEOsust }}$ | Collector-emitter sustaining voltage | $I_{B}^{B}=0 A ; I_{C}=100 \mathrm{~mA} ;$ | 800 |  |  | V |
| $\mathrm{V}_{\text {CEsat }}$ | Collector-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=8.0 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=1.6 \mathrm{~A}$ | - |  | 5.0 | V |
| $\mathrm{V}_{\text {BEssat }}^{\text {CEsat }}$ | Base-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=8.0 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=1.6 \mathrm{~A}$ |  | - | 1.3 | V |
| $\mathrm{h}_{\text {FE }}$ | DC current gain | $\mathrm{I}_{\mathrm{C}}=100 \mathrm{~mA} ; \mathrm{V}_{\text {CE }}=5 \mathrm{~V}$ | 6 | 13 | 26 |  |
| $\mathrm{h}_{\text {FE }}$ |  | $\mathrm{I}_{\mathrm{C}}=8 \mathrm{~A} ; \mathrm{V}_{\text {CE }}=5 \mathrm{~V}$ | 5 | 7 | 10 |  |

## DYNAMIC CHARACTERISTICS

$\mathrm{T}_{\text {hs }}=25^{\circ} \mathrm{C}$ unless otherwise specified

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {c }}$ | Collector capacitance | $\mathrm{I}_{\mathrm{E}}=0 \mathrm{~A} ; \mathrm{V}_{\mathrm{CB}}=10 \mathrm{~V} ; \mathrm{f}=1 \mathrm{MHz}$ | 145 | - | pF |
| $\mathrm{t}_{\text {s }}$ | Switching times ( 32 kHz line deflection circuit) <br> Turn-off storage time Turn-off fall time |  | $\begin{aligned} & 3.0 \\ & 0.2 \end{aligned}$ | $\begin{gathered} 4.0 \\ 0.35 \\ \hline \end{gathered}$ | $\begin{array}{r} \mu \mathrm{s} \\ \mu \mathrm{~s} \\ \hline \end{array}$ |

[^1]
## Silicon Diffused Power Transistor



Fig.1. Test circuit for $V_{\text {CEOsust }}$


Fig.2. Oscilloscope display for $V_{\text {CEOsust }}$.


Fig.3. Switching times waveforms.


Fig.4. Switching times definitions.


Fig.5. Switching times test circuit.


Fig.6. Typical $D C$ current gain. $h_{F E}=f\left(I_{C}\right)$ parameter $V_{C E}$


Fig.7. Typical base-emitter saturation voltage. $V_{B E} s a t=f\left(I_{C}\right) ;$ parameter $I_{C} I_{B}$


Fig.8. Typical collector-emitter saturation voltage. $V_{C E} S a t=f\left(I_{C}\right) ;$ parameter $I_{C} I_{B}$


Fig.9. Typical base-emitter saturation voltage. $V_{B E}$ sat $=f\left(I_{B}\right)$; parameter $I_{C}$


Fig.10. Typical collector-emitter saturation voltage. $V_{C E}$ sat $=f\left(I_{B}\right)$; parameter $I_{C}$


Fig.11. Typical turn-off losses. $T_{b}=85^{\circ} \mathrm{C}$ Eoff $=f\left(I_{B}\right) ;$ parameter $I_{C} ; f=32 \mathrm{kHz}$


Fig.12. Typical collector storage and fall time. ts $=f\left(I_{B}\right) ; t f=f\left(I_{B}\right) ;$ parameter $I_{C} ; T_{j}=85^{\circ} \mathrm{C} ; f=32 \mathrm{kHz}$


Fig.13. Normalised power dissipation. $P D \%=100 \cdot P_{D} / P_{D 25^{\circ} \mathrm{C}}=f\left(T_{h s}\right)$


Fig.14. Transient thermal impedance.
$Z_{\text {th } j \text {-hs }}=f(t) ;$ parameter $D=t_{p} / T$


Fig.15. Forward bias safe operating area. $T_{h s}=25^{\circ} \mathrm{C}$ $I_{C D C} \& I_{C M}=f\left(V_{C E}\right) ; I_{C M}$ single pulse; parameter $t_{p}$ Second-breakdown limits independant of temperature. Mounted with heatsink compound.

## MECHANICAL DATA



Fig.16. SOT199; The seating plane is electrically isolated from all terminals.

## Notes

1. Refer to mounting instructions for F-pack envelopes.
2. Epoxy meets UL94 V0 at 1/8".

## Silicon Diffused Power Transistor

## DEFINITIONS

| Data sheet status |  |
| :--- | :--- |
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one <br> or more of the limiting values may cause permanent damage to the device. These are stress ratings only and <br> operation of the device at these or at any other conditions above those given in the Characteristics sections of <br> this specification is not implied. Exposure to limiting values for extended periods may affect device reliability. |
| Application information | Where application information is given, it is advisory and does not form part of the specification. |
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## LIFE SUPPORT APPLICATIONS

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[^0]:    1 Turn-off current.

[^1]:    2 Measured with half sine-wave voltage (curve tracer).

